

FORM PTO-1449 (REV. 7-80) OFFICE	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK	ATTY DOCKET NO. 510.1117	APPLICATION NO 10/523,067
LIST OF PRIOR ART CITED BY APPLICANT		APPLICANT Felix BLANK, et al.	
		FILING DATE 08/05/2005	GROUP 1.795

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE IF APPROPRIATE
	A01 US 6,566,001	May 20, 2003	Yosida et al.	429	30	
	A02 US 5,804,326	Sep. 8, 1998	Chow et al.	429	26	
	A03 US 7,354,670	Apr. 8, 2008	Enjoli et al.	429	22	
	A04 US 6,461,754	Oct. 8, 2002	Zeng	429	26	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	YES	NO
	A05 JP 6-119931	Apr. 28, 1994	JP - Japan			English abstract; JPO computer translation		
	A06 JP 11-312531	Nov. 9, 1999	JP - Japan			English abstract; JPO computer translation		
	A07 JP 06-068896	Mar. 11, 1994	JP - Japan			English abstract; JPO computer translation		
	A08 JP 2001-185172	Jul. 6, 2001	JP - Japan			See US 6,566,001; English abstract		
	A09 JP 10-284095	Oct. 23, 1998	JP - Japan			English abstract; JPO computer translation		
	A10 JP 06-068886	Mar. 11, 1994	JP - Japan			English abstract; JPO computer translation		
	A11 JP 2001-506399T	May 15, 2001	JP - Japan			See US 5,804,326, English abstract		
	A12 JP 2001-143741	May 25, 2001	JP - Japan			English abstract; JPO computer translation		
	A13 JP 7-022059	Jan. 24, 1995	JP - Japan			English abstract; JPO computer translation		
	A14 JP 2001-250568	Sep. 14, 2001	JP - Japan			English abstract; JPO computer translation		
	A15 JP 2000-082482	Mar. 21, 2000	JP - Japan			English abstract; JPO computer translation		
	A16 JP 2000-012051	Jan. 14, 2000	JP - Japan			English abstract; JPO computer translation		
	A17 JP 2001-043871	Feb. 16, 2001	JP - Japan			See US 6,461,754, English abstract		
	A18 JP 2004-031135	Jan. 29, 2004	JP - Japan			See US 7,354,670, English abstract		

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

A19	

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DATE CONSIDERED 06/16/2009

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.